

Notice of References Cited	Application/Control No. 10/536,877	Applicant(s)/Patent Under Reexamination DE WAELE ET AL.	
	Examiner Paul Ip	Art Unit 2837	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0113129	06-2006	Tabata, Atsushi	180/065.2
*	B	US-2003/0217559	11-2003	Ieda et al.	62/230
*	C	US-2003/0116367	06-2003	Kanno, Yoshihito	180/65.1
*	D	US-6,645,653	11-2003	Kashiwagi, Naoto	429/22
*	E	US-6,447,939	09-2002	Iwasaki, Yasukazu	429/9
*	F	US-6,158,537	12-2000	Nonobe, Yasuhiro	180/65.3
*	G	US-5,964,309	10-1999	Kimura et al.	180/65.8
*	H	US-5,929,594	07-1999	Nonobe et al.	320/104
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.